Testing Exponentiality Against a Trend Change in Mean Time to Failure in Age Replacement

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Abstract

Mean time to failure in age replacement evaluates the performance and effectiveness of the age replacement policy. In this paper, we propose a test for exponentiality against a trend change in mean time to failure in age replacement. We derive the asymptotic distribution of the test statistics under the null hypothesis to approximate the critical values. We conduct a simulation study to investigate the performance of the proposed test and compare it with some well known tests in the literature.

Keywords : BFR distribution, Durbin's approximation, Mean time to failure, Nonmonotonic aging class, NWBUE distribution, Total time on test transform.

1 Introduction

The failure of a component or a system during is usually costly or dangerous. It is a common practice to employ a maintenance policy to prevent the item from the failure during operation. The most common and popular maintenance policy is the age replacement policy in which an item is replaced by a new one upon failure or at a known age t, whichever comes first. Let F be the lifetime distribution of a new item and $X_{[t]}$ denote the time to the first in-service failure of an item under the age replacement policy with the age replacement time t. Then the reliability function of $X_{[t]}$ (denoted by R_t) is given by

 $R_t(x) = [\overline{F}(t)]^n \overline{F}(x - nt), \quad nt \le x < (n+1)t, \quad n = 0, 1, \dots,$

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where $\overline{F} = 1 - F$ (Barlow and Proschan, 1965). To evaluate the performance and effectiveness of the age replacement policy, Barlow and Proschan (1965) introduced the mean of $X_{[t]}$, which is called the mean time to failure (MTTF) in the age replacement policy. Let us denote $M_F(t) = E(X_{[t]})$. It is known that

$$M_F(t) = \frac{\int_0^t \overline{F}(x) dx}{F(t)}, \quad t > 0$$
(1.1)

(Kayid et al. 2013; Izadi et al., 2018).

Study the behaviour of $M_F(t)$ with respect to t might lead us to realize the optimal replacement time which makes the MTTF of practical importance. The distribution F is said to be decreasing mean time to failure (DMTTF) in age replacement if $M_F(t)$ is decreasing in $t \in (0, \infty)$ which means a kind of "deterioration". The dual class of increasing mean time to failure (IMTTF) in age replacement is defined by changing the sense of the monotonicity and means "non-deterioration" or improvement in some senses. The ageing classes DMTTF and IMTTF have been studied in the literature by many researchers. Klefsjö (1982) investigated the relationship between DMTTF and IMTTF and some well known aging classes of distributions. Knopik (2005) showed that the DMTTF and IMTTF classes are closed under formation of parallel and series systems. Knopik (2006) further studied the relationship between the DMTTF (IMTTF) class and the increasing (decreasing) failure rate in average (IFRA (DFRA)) class of distributions and showed that the DMTTF is closed under weak convergence of distribution and convolution. Li and Xu (2008) introduced the NBUR_{rh} class of life distributions which is equivalent to the DMTTF class. They studied various properties of the DMTTF class and provided a test for exponentiality against monotone MTTF. Asha and Nair (2010) studied some properties of the quantile based MTTF function by examining its relationship with hazard (reversed hazard) rate and mean (reversed mean) residual life functions. They also defined a new stochastic ordering of life distributions based on MTTF and studied its relationship with some known orderings useful in reliability analysis. Kayid et al. (2013) studied the preservation properties of the MTTF order under monotonic transformations, mixture, and weighted distributions. The problem of testing exponentiality against the DMTTF property has been considered in Kayid et al. (2013) and Kattumannil and Anisha (2016).

The ageing patterns in the above classes are monotone. But, in practical situations, it is often seen that the ageing pattern is non-monotonic. In order to model such situations, various non-monotonic ageing classes have been defined in the literature, see for example, Glaser (1980), Rajarshi and Rajarshi (1988), Klefsjö (1989), Deshpande and Suresh (1990), Mitra and Basu (1994), Belzunce et al. (2007).

Izadi et al. (2018) proposed the following two non-parametric classes of distributions with non-monotonic MTTF function.

Definition 1.1. A life distribution F is said to be an increasing then decreasing mean time to failure (IDMTTF) (decreasing then increasing mean time to failure (DIMTTF)) distribution if there exists a turning point $\tau \geq 0$ such that $M_F(t)$ is increasing (decreasing) on $(0, \tau]$ and decreasing (increasing) on (τ, ∞) .

The IDMTTF class of distributions models a situation that the effect of age replacement is initially beneficial and then adverse and the DIMTTF class of distributions can be used to model the cases when the effect of age replacement is initially adverse and then beneficial. In the IDMTTF class of distributions, $M_F(t)$ is maximum at the change point, so it may be taken as a possible optimal age replacement. Thus, the change point of $M_F(t)$ is important in the IDMTTF distributions which makes this class of distributions of great interest in connection with the age replacement optimization. One of the most used criteria to determine the optimal replacement time is minimizing the expected cost rate (cf. Nakagawa , 2005). Izadi et al. (2018) studied the relationship between the MTTF function and the expected cost rate function. They investigated how τ approximates the optimal replacement time which minimizes the expected cos rate function. Izadi et al. (2018) also studied the implications between the IDMTTF and DIMTTF classes of distributions and some existing classes of non-monotonic aging classes.

Let F be a lifetime distribution with finite mean μ_F , density function f and failure rate function $r_F(t) = \frac{f(t)}{\overline{F(t)}}$. It is said that F is bathtub (upside-down) failure rate (BFR (UBFR)), if there exists $t_0 \ge 0$ such that $r_F(t)$ is decreasing (increasing) in $0 \le t < t_0$ and increasing (decreasing) in $t \ge t_0$; F is NWBUE (NBWUE) if there exists $t^* \ge 0$ such that $\mu_F \le (\ge) \frac{\int_t^{\infty} \overline{F(x)}}{\overline{F(t)}}$ for $t \le t^*$ and $\mu_F \ge (\le) \frac{\int_t^{\infty} \overline{F(x)}}{\overline{F(t)}}$ for $t > t^*$.

Izadi et al. (2018) showed that

$$BFR \Longrightarrow IDMTTF \Longrightarrow NWBUE$$
 and $UBFR \Longrightarrow DIMTTF \Longrightarrow NBWUE$.

A reasonable starting point in reliability analysis is to determine the ageing class of the underlying distribution F. In view of this consideration, the statistical problem of testing whether the lifetime distribution F belongs to a specific monotonic or non-monotonic ageing class has been received considerable attention in the literature; see for instance Guess et al. (1986), Klefsjö (1989), Hawkins et al. (1992), Hawkins and Kochar (1997), Lai (1994), Na et al. (2005), Lai and Xie (2006), Anis (2014) and Anis and Ghosh (2015) among others. The problem of testing whether F is DMTTF has also been recently studied by Li and Xu (2008), Kayid et al. (2013) and Kattumannil and Anisha (2016).

Let \mathcal{E} denote the exponential family of distributions, that is, $\mathcal{E} = \{F | F(x) = \lambda e^{-\lambda x}, \lambda > 0\}$ and let

 $\mathcal{F}_{ID} = \{F | F \text{ is an IDMTTF distribution and not exponential}\}$

and

 $\mathcal{F}_{DI} = \{F | F \text{ is an DIMTTF distribution and not exponential} \}.$

In this paper we are interested the problem of testing

$$H_0$$
 : $F \in \mathcal{E}$

against

$$H_1 : F \in \mathcal{F}_{ID} \tag{1.2}$$

based on the random sample X_1, X_2, \ldots, X_n from distribution F. When the dual model is considered, we test H_0 against

$$H_1': F \in \mathcal{F}_{DI}.\tag{1.3}$$

The organization of the paper is as follows. In the next section, we propose a test for the considered problem of hypothesis testing and obtain the asymptotic null distribution of the test statistic. The performance of the proposed test is investigated by simulation study in Section 3.

2 Test for trend change

Let F be a lifetime distribution with finite mean μ_F , density function f and reliability function $\overline{F} = 1 - F$. Taking derivative of $M_F(t)$ with respect to t, it can be shown that Fis IDMTTF with the change point $\tau \ge 0$, if and only if

$$\omega(t) = F(t)\overline{F}(t) - f(t) \int_0^t \overline{F}(x)dx \begin{cases} \ge 0, & t < \tau \\ \le 0, & t \ge \tau. \end{cases}$$

Let us define

$$\gamma(F,t) = \int_0^t \omega(x) dx - \int_t^\infty \omega(x) dx, \quad 0 \le t < \infty$$

and

$$\gamma(F) = \sup\{\gamma(F,t); 0 \le t < \infty\}.$$

Under the null hypothesis $H_0: F$ is an exponential distribution, $\omega(t) = 0$ for all $t \ge 0$ which implies $\gamma(F) = 0$. Taking derivative of $\gamma(F, t)$, it is easy to see that under the alternative hypothesis $H_1: F$ is IDMTTF and not exponential, $\gamma(F, t)$ is increasing for $t < \tau$ and decreasing for $t \ge \tau$ and hence $\gamma(F) = \gamma(F, \tau) > 0$. Thus we can use $\gamma(F)$ as a measure of departure from H_0 in favor of H_1 . It can easily be seen that

$$\begin{split} \gamma(F,t) &= 2(1+\overline{F}(t)) \int_0^t \overline{F}(x) dx - 2 \int_0^\infty \overline{F}^2(x) dx + 4 \int_t^\infty \overline{F}^2(x) dx - \mu_F \\ &= 2(1+\overline{F}(t)) \int_0^\infty \overline{F}(x) dx - 2 \int_0^\infty \overline{F}^2(x) dx \\ &+ \int_t^\infty \overline{F}(x) [4\overline{F}(x) - 2(1+\overline{F}(t))] dx - \mu_F \end{split}$$

Now, let X_1, \ldots, X_n be a random sample from F and $X_{(1)}, \ldots, X_{(n)}$ denote the corresponding order statistics, F_n the empirical distribution function and \overline{X} the sample mean. Set $X_{(0)} \equiv 0$ and $X_{(n+1)} \equiv \infty$. The test statistic for testing H_0 against H_1 can be estimate of $\gamma(F)$ by replacing F by F_n as follows:

$$\gamma(F_n) = \sup\{\gamma(F_n, t); 0 \le t < \infty\}$$

=
$$\max_{0 \le k \le n} \sup\{\gamma(F_n, t); X_{(k)} \le t < X_{(k+1)}\}.$$

For $X_{(k)} \leq t < X_{(k+1)}$, we have

$$\begin{split} \gamma(F_n,t) &= 2(1+\overline{F}_n(t)) \int_0^\infty \overline{F}_n(x) dx - 2 \int_0^\infty \overline{F}_n^2(x) dx - \mu_{F_n} \\ &+ \int_{X_{(k+1)}}^\infty \overline{F}_n(x) [4\overline{F}_n(x) - 2(1+\overline{F}_n(t))] dx \\ &+ \int_t^{X_{(k+1)}} \overline{F}_n(x) [4\overline{F}_n(x) - 2(1+\overline{F}_n(t))] dx \\ &= 2(2-\frac{k}{n}) \sum_{i=0}^{n-1} (1-\frac{i}{n}) D_i - \sum_{i=0}^{n-1} (1-\frac{i}{n})^2 D_i - \sum_{i=0}^{n-1} (1-\frac{i}{n}) D_i \\ &+ \sum_{i=k+1}^{n-1} (1-\frac{i}{n}) [4(1-\frac{i}{n}) - 2(2-\frac{k}{n})] D_i - 2(X_{(k+1)} - t) \frac{k}{n} (1-\frac{k}{n}) \end{split}$$

where $D_i = X_{(i+1)} - X_{(i)}, i = 0, 1, \dots, n-1$. Thus,

$$\sup_{X_{(k)} \le t < X_{(k+1)}} \gamma(F_n, t) = 2\left(2 - \frac{k}{n}\right) \sum_{i=0}^{n-1} \left(1 - \frac{i}{n}\right) D_i - \sum_{i=0}^{n-1} \left(1 - \frac{i}{n}\right)^2 D_i - \sum_{i=0}^{n-1} \left(1 - \frac{i}{n}\right) D_i + \sum_{i=k+1}^{n-1} \left(1 - \frac{i}{n}\right) \left[4\left(1 - \frac{i}{n}\right) - 2\left(2 - \frac{k}{n}\right)\right] D_i$$

and hence

$$\gamma(F_n) = \max_{0 \le k \le n} \zeta_{n,k}$$

where

$$\zeta_{n,k} = \sum_{i=0}^{n-1} A_n D_i + \sum_{i=k+1}^{n-1} B_n D_i,$$

$$A_n = -2(1 - \frac{i}{n})^2 - (1 - \frac{i}{n}) + 2(2 - \frac{k}{n})(1 - \frac{i}{n}), \ B_n = 4(1 - \frac{i}{n})^2 - 2(2 - \frac{k}{n})(1 - \frac{i}{n}).$$

The IDMTTF class of distributions is closed under the scale transformation, that is, if the random variable X is IDMTTF, then aX is also IDMTTF for every a > 0. Since $\gamma(F_n)$ is not scale invariant, we use the test statistic

$$\gamma^*(F_n) = \frac{\sqrt{n\gamma(F_n)}}{\overline{X}}.$$

which makes the test-scale invariant.

In the next theorem, we obtain the asymptotic distribution of $\gamma^*(F_n)$ under the null hypothesis.

Theorem 2.1. Let Z(u) be a mean zero Gaussian process with covariance

$$\rho(s,t) = \frac{2}{3}(s^3 - t^3) + \frac{1}{3}, \qquad 0 \le s \le t \le 1.$$
(2.4)

Under H_0 ,

$$\gamma^*(F_n) \xrightarrow{D} Z = \sup\{Z(u); 0 \le u \le 1\},\$$

as $n \to \infty$.

Proof: We recall that

$$\gamma(F,t) = 2(1+\overline{F}(t))\int_0^t \overline{F}(x)dx - 2\int_0^\infty \overline{F}^2(x)dx + 4\int_t^\infty \overline{F}^2(x)dx - \mu_F(x)dx + 4\int_t^\infty \overline{F}^2(x)dx +$$

By the theory of Von-Mises differentiable statistical function, we have that

$$\gamma(F_n, t) - \gamma(F, t) = D_1 \gamma(F, t) (F_n - F) + R_n(F, t)$$
(2.5)

where $R_n(F, t)$ is the remainder term and $D_1\gamma(F, t)(F_n - F)$ is Găteaux differential of $\gamma(F, t)$ at F in direction F_n and given by

$$D_1\gamma(F,t)(F_n-F) = \frac{d}{d\lambda}\gamma(F+\lambda(F_n-F),t)|_{\lambda=0+1}$$

(see Serfling (1980), Chapter 6). It is easy to see that

$$D_{1}\gamma(F,t)(F_{n}-F) = -2(F_{n}(t)-F(t))\int_{0}^{t}\overline{F}(x)dx - 2(1+\overline{F}(t))\int_{0}^{t}(F_{n}(x)-F(x))dx + 4\int_{0}^{\infty}(F_{n}(x)-F(x))\overline{F}(x)dx - 8\int_{t}^{\infty}(F_{n}(x)-F(x))\overline{F}(x)dx + \int_{0}^{\infty}(F_{n}(x)-F(x))dx.$$

After some algebraic manipulations, we obtain

$$R_n(F,t) = \gamma(F_n,t) - \gamma(F,t) - D_1\gamma(F,t)(F_n - F)$$

= $-2\int_0^\infty (\overline{F}_n(x) - \overline{F}(x))^2 dx + 4\int_t^\infty (\overline{F}_n(x) - \overline{F}(x))^2 dx$
 $+2(\overline{F}_n(t) - \overline{F}(t))\int_0^t (\overline{F}_n(x) - \overline{F}(x)) dx.$

For every $t \ge 0$,

$$\sqrt{n}|R_n(F,t)| \le 8\sqrt{n}\sup|F_n(x) - F(x)| \int_0^\infty |F_n(x) - F(x)| dx.$$

By the classical results on the Kolmogorov-Smirnov statistics, we have $\sqrt{n} \sup |F_n(x) - F(x)| = O_p(1)$. Also, $\int_0^\infty |F_n(x) - F(x)| dx = o_p(1)$ (Hawkins et al. (1992), page 288). Thus $\sqrt{n}R_n(F,t) = o_p(1)$.

Let us define the stochastic process $Z_n(F) = \{Z_n(u, F) : 0 \le u \le 1\}$ where

$$Z_n(u;F) = n^{\frac{1}{2}} D_1 \gamma(F, F^{-1}(u))(F_n - F).$$

By (2.5), under the null hypothesis,

$$\sqrt{n\gamma}(F_n, F^{-1}(u)) = Z_n(u; F) + \sqrt{nR_n}(F, F^{-1}(u)), \quad 0 \le u \le 1,$$
(2.6)

where F^{-1} is the quantile function corresponding to F. Thus, to obtain the required result, it suffices to show that under the null hypothesis

$$\overline{X}^{-1}Z_n(u;F) \xrightarrow{D} Z(u), \quad 0 \le u \le 1$$

where Z(u) is a mean-zero Gaussian process with covariance (2.4). Now, we have that

$$n^{-\frac{1}{2}}Z_{n}(u;F) = -2(F_{n}(F^{-1}(u)) - u) \int_{0}^{F^{-1}(u)} \overline{F}(x)dx - 2(2 - u) \int_{0}^{F^{-1}(u)} (F_{n}(x) - F(x))dx + 4 \int_{0}^{\infty} (F_{n}(x) - F(x))\overline{F}(x)dx - 8 \int_{F^{-1}(u)}^{\infty} (F_{n}(x) - F(x))\overline{F}(x)dx + \int_{0}^{\infty} (F_{n}(x) - F(x))du.$$

Let us define $W_n(x) = n^{\frac{1}{2}}(F_n(F^{-1}(x)) - x), 0 \le x \le 1$. Now, under the null hypothesis H_0 : F is an exponential distribution with mean β ,

$$\beta^{-1}Z_n(u;F) = -2uW_n(u) - 2(2-u)\int_0^u \frac{W_n(x)}{1-x}dx + 4\int_0^1 W_n(x)dx$$
$$-8\int_u^1 W_n(x)dx + \int_0^1 \frac{W_n(x)}{1-x}dx$$

Since $W_n(x)$, $0 \le x \le 1$ converges to a Browanian bridge, W(x), with covariance E(W(s)W(t)) = s(1-t), $s \le t$ (see Serfling (1980), p. 110) and $\overline{X} \xrightarrow{a.s.} \beta$, the required result follows.

Now, in order to find the critical points of $\gamma^*(F_n)$ and

$$P\{Z > c\} = P\{\sup_{0 \le u \le 1} Z(u) > c\},$$
(2.7)

we use Durbin's (1985) approximation. Suppose that y(u) is a continuous Gaussian process with covariance function $\rho(s,t)$, $0 \le s \le t$ and let

$$T_{u_0} = \inf_{u > u_0} \{ u : y(u) > c(u) \}$$

denote the first-passage time of y(u) to a boundary c(u) at time $u = u_0$. Durbin (1985) approximated the density function of the first-passage, g(t), by

$$g(t) \simeq b(t)f(t) \tag{2.8}$$

where

$$b(t) = \frac{c(t)}{\rho(t,t)} \frac{\partial \rho(s,t)}{\partial s}|_{s=t} - c'(t).$$
(2.9)

and

$$f(t) = (2\pi\rho(t,t))^{\frac{-1}{2}} \exp\{\frac{-c^2(t)}{2\rho(t,t)}\}\$$

Now, suppose c(u) = c, then using Durbin's approximation we can approximate (2.7) for large value of c, the probability that Z(u) crosses c in [0, 1], as follows:

$$P\{Z > c\} = P\{\sup_{0 \le u \le 1} Z(u) > c\}$$
$$= P(0 \le T_0 \le 1)$$
$$= \int_0^1 g(t) dt$$

where

$$g(t) \simeq \frac{6\sqrt{3}ct^2}{\sqrt{2\pi}} \exp\{-\frac{3c^2}{2}\}$$

and thus

$$P\{Z > c\} \simeq \frac{2\sqrt{3}c}{\sqrt{2\pi}} \exp\{\frac{-3c^2}{2}\}.$$
 (2.10)

In Table 1, using (2.10), we provide some approximated values of critical points of $\gamma^*(F_n)$, c, such that $P\{Z > c\} = \alpha$, for some commonly used levels of significance.

Table 1: Approximated critical points of $\gamma^*(F_n)$

α	0.01	0.025	0.05	0.1
С	1.9298	1.7453	1.5878	1.4065

As for the problem of testing H_0 against H'_1 given as in (1.3), the measure of departure from H_0 in favor of H'_1 is

$$\kappa(F) = \sup\{-\gamma(F,t); 0 \le t < \infty\}.$$
(2.11)

Similar to the test for H_0 against H_1 , we propose to reject H_0 in favor of H'_1 for large values of

$$\kappa^*(F_n) = \frac{\sqrt{n} \max_{0 \le k \le n} \eta_{n,k}}{\overline{X}}$$

where

$$\eta_{n,k} = \sum_{i=0}^{n-1} C_{k,i} D_i + \sum_{i=k}^{n-1} E_{k,i} D_i$$

and

$$C_{k,i} = 2\left(1 - \frac{i}{n}\right)^2 + \left(1 - \frac{i}{n}\right) - 2\left(2 - \frac{k}{n}\right)\left(1 - \frac{i}{n}\right), \ E_{k,i} = 2\left(2 - \frac{k}{n}\right)\left(1 - \frac{i}{n}\right) - 4\left(1 - \frac{i}{n}\right)^2.$$

From the proof of Theorem 2.1, it can be seen that $\gamma^*(F_n)$ and $\kappa^*(F_n)$ have identical asymptotic distribution. Thus, the values given in Table 1 can be used as the critical points of the test statistic κ^* for large sample sizes.

3 A simulation study

In this section, we study the performance of the proposed tests. First, to investigate the speed of convergence of the test statistics $\gamma^*(F_n)$ and $\kappa^*(F_n)$ to Z and accuracy the approximated critical points given in Table 1, we obtained the empirical sizes at some different nominal sizes (levels of significance). Since our test statistics are scale invariant, we generated 10000 random samples from exponential distribution with mean 1. The values, presented in Table 2, are the fraction of times that H_0 is rejected at some levels of significance, i.e., the test statistic is greater than the asymptotic critical value at the given nominal sizes. The results indicate that the tests have type I error rates far from the nominal sizes for small sample sizes. So, in Table 3 below, we obtained the critical points of γ^* and κ^* by simulation for small sample sizes n = 10(5)70 and some commonly used levels of significance. To compute the critical points, 10000 samples were generated from the exponential distribution.

			γ^*			κ^*						
n	α	0.01	0.025	0.05	0.1	0.01	0.025	0.05	0.1			
10		0.0089	0.0292	0.0654	0.1447	0.0013	0.0050	0.0119	0.0341			
15		0.0107	0.0323	0.0681	0.1478	0.0020	0.0055	0.0150	0.0407			
20		0.0124	0.0346	0.0759	0.1512	0.0024	0.0080	0.0197	0.0495			
25		0.0113	0.0310	0.0665	0.1409	0.0021	0.0095	0.0235	0.0540			
30		0.0139	0.0366	0.0699	0.1450	0.0036	0.0101	0.0224	0.0565			
35		0.0123	0.0332	0.0719	0.1415	0.0042	0.0122	0.0260	0.0621			
40		0.0134	0.0349	0.0719	0.1429	0.0044	0.0119	0.0288	0.0649			
45		0.0129	0.0336	0.0693	0.1403	0.0040	0.0119	0.0268	0.0654			
50		0.0138	0.0375	0.0686	0.1405	0.0052	0.0123	0.0291	0.0673			
55		0.0141	0.0338	0.0700	0.1392	0.0051	0.0136	0.0302	0.0690			
60		0.0124	0.0310	0.0661	0.1352	0.0048	0.0132	0.0305	0.0737			
65		0.0142	0.0325	0.0674	0.1379	0.0045	0.0142	0.0310	0.0711			
70		0.0127	0.0350	0.0706	0.1443	0.0050	0.0143	0.0322	0.0717			
100		0.0122	0.0336	0.0649	0.1330	0.0060	0.0168	0.0377	0.0830			
200		0.0115	0.0287	0.0645	0.1233	0.0066	0.0201	0.0423	0.0879			

Table 2: Empirical sizes of the tests $\gamma^*(F_n)$ and $\kappa^*(F_n)$.

Table 3: $(1 - \alpha)$ -quantile of γ^* and κ^* .

			γ^*				κ^*			
n	α	0.01	0.025	0.05	0.1		0.01	0.025	0.05	0.1
10		1.9179	1.7747	1.6429	1.5005		1.5908	1.3947	1.2277	1.0702
15		1.9389	1.8013	1.6584	1.5039		1.5922	1.4050	1.2461	1.0846
20		1.9636	1.8157	1.6755	1.5206		1.5839	1.3979	1.2532	1.0792
25		1.9501	1.7870	1.6485	1.4995		1.6283	1.4172	1.2823	1.1028
30		1.9759	1.8343	1.6587	1.5014		1.5976	1.4318	1.2830	1.1102
35		1.9659	1.8015	1.6617	1.5064		1.5671	1.4247	1.2971	1.1242
40		1.9759	1.8208	1.6655	1.5066		1.6197	1.4384	1.3033	1.1402
45		1.9758	1.8103	1.6656	1.4897		1.6513	1.4612	1.3184	1.1605
50		1.9825	1.8180	1.6734	1.5000		1.6480	1.4697	1.3204	1.1581
55		1.9720	1.7996	1.6669	1.4961		1.6871	1.4942	1.3496	1.1894
60		1.9672	1.7856	1.6495	1.4855		1.6722	1.4921	1.3504	1.1840
65		1.9834	1.7971	1.6541	1.4943		1.6507	1.4942	1.3654	1.2063
70		1.9719	1.8056	1.6675	1.5021		1.6878	1.5247	1.3740	1.2044

Since there is no other test for our considered problem and the IDMTTF (DIMTTF) test may also be used to test exponentiality against BFR (UBFR) alternative, it would be beneficial to compare it to some BFR (UBFR) tests. Na et al. (2005) proposed a test for the problem of testing exponentiality against BFR property based on the measure

$$T(F) = \sup\{\phi(x;F) : x \ge 0\}$$
(3.12)

where

$$\phi(x;F) = (1 - \overline{F}(x)) \int_0^x \overline{F}(t)dt - 2\int_0^x \overline{F}^2(t)dt - \overline{F}(x) \int_x^\infty \overline{F}(t)dt + 2\int_x^\infty \overline{F}^2(t)dt.$$

Their test statistic is

$$T^* = \frac{\sqrt{n}T(F_n)}{\overline{X}} \tag{3.13}$$

where $T(F_n)$ is obtained by replacing F by F_n in (3.12). There is a slight mistake in the formula for $T(F_n)$ in Na et al. (2005). It is not difficult to see that

$$T(F_n) = \max_{0 \le k \le n} \{\eta_1(k) - 2\eta_2(k) + \eta_3(k)\}$$

where for $k = 0, \ldots, n$,

$$\eta_1(k) = \sum_{i=1}^k \frac{n-i+1}{n} D_{i-1},$$

$$\eta_2(k) = \sum_{i=k+1}^n \left[(\frac{n-k}{n})(\frac{n-i+1}{n}) - 2(\frac{n-i+1}{n})^2 \right] D_{i-1},$$

$$\eta_3(k) = \sum_{i=1}^n \left[(\frac{n-k}{n})(\frac{n-i+1}{n}) - 2(\frac{n-i+1}{n})^2 \right] D_{i-1}.$$

The large values of T^* reject the exponentiality against BFR property. Na et al. (2005) have also proposed to reject exponentiality against UBFR property for large values of

$$U^* = \frac{\sqrt{n} \max_{0 \le k \le n} \{2\eta_2(k) - \eta_1(k) - \eta_3(k)\}}{\overline{X}}.$$
(3.14)

Another well known BFR test is the one proposed by Aarset (1985) which rejects H_0 in favor of BFR property for large values of

$$G_n = V_n + n - M_n$$

where

$$V_n = \min\{1 \le i \le n : U_i \ge \frac{i}{n}\},$$

$$M_n = \max\{0 \le i \le n - 1 : U_i \le \frac{i}{n}\}$$

and

$$U_{i} = \frac{\sum_{j=1}^{i} (n-j+1)D_{j}}{\sum_{j=1}^{n} (n-j+1)D_{j}}, \quad i = 1, \dots, n, \quad U_{0} = 0.$$
(3.15)

The small values of G_n reject exponentiality in favor of UBFR. Aarset (1985) has derived the exact null distribution of G_n which takes integer values in [2, n + 1].

To compare three tests, we use the simulated power of the tests. For a fair comparison, we use the simulated critical points of our test and the test proposed by Na et al. (2005). We also employ the randomized version of the test of Aarset (1985). In the alternative hypothesis, we first consider the exponential power distribution which has been studied by Smith and Bain (1975), Dhillon (1981), Paranjpe and Rarjarshi (1986). The exponential power model has survival function and failure rate function given by

$$\overline{F}(x) = \exp\{-(e^{(\lambda x)^{\beta}} - 1)\}$$

and

$$r(t) = \lambda \beta(\lambda t)^{\beta - 1} e^{(\lambda t)^{\beta}},$$

respectively. For $\beta < 1$, r(t) yields a bathtub shape (Lai and Xie, 2006). Since BFR implies IDMTTF (Izadi et al., 2018), thus the exponential power is IDMTTF for $\beta < 1$. In Table 4, we simulate the power of the IDMTTF test (γ^*), Na et al.'s test (T^*) and Aarset's test (G_n) at significance levels $\alpha = 0.01, 0.05$ and 0.1 by generating 10000 samples with sizes n = 10(10)60 and from the exponential power distribution with $\lambda = 1$ and some values of the parameter $\beta < 1$. The results indicate that our test and the test of Na et al. (2005) dominate Aarset's test for all cases in the alternative. For the values of β closed to 1, the test of Na et al. (2005) performs better than our test, while our test is more powerful for the other cases.

The random variable X has a lognormal distribution with parameters μ and σ if $\ln X$ has a normal distribution with mean μ and variance σ^2 . It is known that the lognormal distribution is UBFR which is also DIMTTF (Izadi et al., 2018). In order to compare our DIMTTF test (κ^*) with respect to Na et al.'s test (U^*) and Aarset's test (G_n), we consider the lognormal distribution in the alternative. In Table 5 below, we simulate the power of the tests at significance levels $\alpha = 0.01, 0.05$ and 0.1 by generating 10000 samples with sizes n = 10(10)60 from the lognormal distribution with $\mu = 0$ and some selected values of σ . From Table 5, a similar observation to that reported for Table 4 can be made. The performance of Aarset test is poor. The new proposed test performs better than the test due to Na et al. for some values of σ and the result is reversed for other values.

		$\beta = 0.1$			$\beta = 0.3$			$\beta = 0.5$			$\beta = 0.7$			$\beta = 0.9$		
n	α	γ^*	G_n	T^*												
10	0.01	0.9805	0.0232	0.9334	0.5118	0.0215	0.2540	0.0815	0.0161	0.0143	0.0118	0.0118	0.0090	0.0229	0.0128	0.0497
	0.05	0.9950	0.1161	0.9814	0.7129	0.1075	0.4767	0.2230	0.0803	0.0637	0.0592	0.0592	0.0528	0.1015	0.0641	0.1647
	0.1	0.9976	0.2322	0.9908	0.8019	0.2150	0.6000	0.3232	0.1605	0.1290	0.1183	0.1183	0.1064	0.1825	0.1281	0.2671
20	0.01	1.000	0.0415	0.9999	0.8503	0.0386	0.7738	0.1581	0.0253	0.0794	0.0291	0.0144	0.0117	0.0523	0.0195	0.0838
	0.05	1.000	0.2073	1.000	0.9392	0.1929	0.9099	0.3437	0.1267	0.2290	0.1063	0.0718	0.0643	0.1743	0.0973	0.2697
	0.1	1.000	0.4147	1.000	0.9656	0.3859	0.9507	0.4639	0.2534	0.3425	0.1867	0.1437	0.1415	0.2788	0.1947	0.4030
30	0.01	1.000	0.0598	1.000	0.9642	0.0559	0.9515	0.2535	0.0352	0.1737	0.0355	0.0165	0.0138	0.0845	0.0281	0.1401
	0.05	1.000	0.2989	1.000	0.9916	0.2797	0.9889	0.4783	0.1758	0.3878	0.1382	0.0824	0.0765	0.2611	0.1406	0.3687
	0.1	1.000	0.5977	1.000	0.9954	0.5595	0.9939	0.6113	0.3516	0.5235	0.2385	0.1649	0.1556	0.3911	0.2811	0.5177
40	0.01	1.000	0.0781	1.000	0.9929	0.0735	0.9935	0.3514	0.0452	0.3053	0.0453	0.0176	0.0194	0.1340	0.0373	0.2185
	0.05	1.000	0.3905	1.000	0.9990	0.3673	0.9990	0.5831	0.2260	0.5353	0.1527	0.0880	0.0918	0.3399	0.1864	0.4632
	0.1	1.000	0.7811	1.000	0.9994	0.7345	0.9994	0.7037	0.4521	0.6538	0.2556	0.1760	0.1788	0.4865	0.3729	0.5926
50	0.01	1.000	0.0965	1.000	0.9983	0.0904	0.9982	0.4373	0.0532	0.4070	0.0536	0.0195	0.0181	0.1727	0.0452	0.2764
	0.05	1.000	0.4824	1.000	1.0000	0.4522	0.9999	0.6657	0.2661	0.6561	0.1838	0.0974	0.1002	0.4133	0.2261	0.5443
	0.1	1.000	0.9649	1.000	1.0000	0.9044	1.0000	0.7821	0.5322	0.7671	0.3037	0.1948	0.2039	0.5777	0.4522	0.6870
60	0.01	1.000	0.1149	1.000	1.000	0.1075	1.000	0.5410	0.0632	0.5167	0.0716	0.0224	0.0194	0.2448	0.0543	0.3480
	0.05	1.000	0.5745	1.000	1.000	0.5376	1.000	0.7623	0.3159	0.7424	0.2232	0.1119	0.1093	0.5129	0.2716	0.6233
	0.1	1.000	1.000	1.000	1.000	0.9874	1.000	0.8523	0.6350	0.8373	0.3517	0.2276	0.2212	0.6651	0.5458	0.7529

Table 4: The simulated power of γ^* , G_n , T^* for the exponential power model in the alternative.

		$\sigma = 0.2$			$\sigma = 0.6$			$\sigma=1$			$\sigma=1.4$			$\sigma = 2$		
n	α	κ^*	G_n	U^*	κ^*	G_n	U^*	κ^*	G_n	U^*	κ^*	G_n	U^*	κ^*	G_n	U^*
10	0.01	1	0.000	1	0.2860	0.0152	0.2868	0.0270	0.0249	0.0202	0.0738	0.0100	0.0562	0.2878	0.0016	0.2751
	0.05	1	0.000	1	0.6166	0.0760	0.6139	0.1179	0.1245	0.0871	0.1886	0.0501	0.1455	0.4785	0.0080	0.4558
	0.1	1	0.000	1	0.7460	0.1521	0.7587	0.1912	0.2489	0.1567	0.2619	0.1001	0.2100	0.5684	0.0160	0.5484
20	0.01	1	0.000	1	0.6461	0.0176	0.6800	0.0768	0.0345	0.0371	0.3139	0.0135	0.2644	0.7610	0.0006	0.7574
	0.05	1	0.000	1	0.8749	0.0878	0.9031	0.2063	0.1723	0.1328	0.4748	0.0677	0.4187	0.8645	0.0031	0.8668
	0.1	1	0.000	1	0.9428	0.1756	0.9571	0.3204	0.3446	0.2349	0.5702	0.1353	0.5120	0.9069	0.0062	0.9053
30	0.01	1	0.000	1	0.8620	0.0173	0.8884	0.1406	0.0386	0.0613	0.5044	0.0173	0.4543	0.9311	0.0004	0.9339
	0.05	1	0.000	1	0.9655	0.0867	0.9765	0.3038	0.1932	0.1898	0.6602	0.0864	0.6214	0.9680	0.0020	0.9712
	0.1	1	0.000	1	0.9878	0.1734	0.9918	0.4245	0.3864	0.3084	0.7333	0.1727	0.7007	0.9792	0.0039	0.9803
40	0.01	1	0.000	1	0.9507	0.0186	0.9619	0.1946	0.0419	0.0809	0.6585	0.0207	0.6120	0.9836	0.0003	0.9841
	0.05	1	0.000	1	0.9934	0.0931	0.9960	0.3883	0.2094	0.2398	0.7868	0.1036	0.7650	0.9939	0.0016	0.9943
	0.1	1	0.000	1	0.9977	0.1861	0.9992	0.5153	0.4188	0.3776	0.8486	0.2071	0.8307	0.9964	0.0032	0.9969
50	0.01	1	0.000	1	0.9853	0.0186	0.9918	0.2548	0.0437	0.1205	0.7568	0.0236	0.7368	0.9961	0.0002	0.9974
	0.05	1	0.000	1	0.9991	0.0930	0.9994	0.4607	0.2186	0.2898	0.8660	0.1180	0.8538	0.9991	0.0011	0.9991
	0.1	1	0.000	1	0.9997	0.1860	0.9998	0.5803	0.4372	0.4261	0.9077	0.2361	0.8977	0.9995	0.0021	0.9997
60	0.01	1	0.000	1	0.9958	0.0191	0.9983	0.3018	0.0445	0.1624	0.8338	0.0265	0.8412	0.9988	0.0000	0.9991
	0.05	1	0.000	1	0.9996	0.0957	0.9999	0.5135	0.2227	0.3645	0.9171	0.1324	0.9196	0.9997	0.0004	0.9998
	0.1	1	0.000	1	1.0000	0.1914	1.0000	0.6407	0.4454	0.5191	0.9446	0.2649	0.9485	0.9999	0.0008	1.0000

Table 5: The simulated power of κ^* , G_n and U^* for the log-normal distribution in the alternative.

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